Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 251961US-3 DIV		SERIAL NO. 10/830,101 10/830, 223				
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-#n	AF	2004-046268	2/2004	JAPAN (w/abstract)					
-thn	AG	09-166912	6/1997	JAPAN (w/abstract)				<del></del>	
<u> </u>	АН	64-17550	1/1989	JAPAN		X			
-11.	Al	2001-175083	6/2001	JAPAN (w/abstract)					
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-#^	AK	11-272075	10/1999	JAPAN (w/abstract)					
#5	AL	10-063087	3/1998	JAPAN (w/abstract)				,	
4~	AM	04-143781	5/1992	JAPAN (w/abstract)					
#,	AN	58-123444	8/1983	JAPAN		×			
th	AO	10-293452	11/1998	JAPAN (w/abstract)					
47	AP	04-134471	5/1992	JAPAN (w/abstract)					
47	AQ	09-022175	1/1997	JAPAN (w/abstract)		-			
47	AR	10-097130	4/1998	JAPAN (w/abstract)	<del></del>				
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4	AP	60-3856	1/12/1985	Japan		×				
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4~	AB	5,412,364	μa	inuary-97	Iguchi et al.	<b></b> '	<b> </b> -	<b></b>		
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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.				
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#,	AA	5,740,507	4/14/98	Ichikawa et al.					
4,	AB	5,655,195	8/5/97	Ichikawa et al.					
-th	AC	5,950,055	9/7/99	Yahata et al.					
<u> </u>	AD	5,915,154	6/22/99	Schoch et al.					
+,	AE	5,570,170	10/29/96	Muranyl et al.					
#"	AF	4,274,455	6/23/81	Simons					
++~	AG	4,945,956	8/7/90	Bueyuekguedue et al.					
Hn .	AH	4,503,625	3/12/85	Manzer					
4	ΑI	5,848,326	12/8/98	Komuro et al.	<u> </u>				
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		LATION NO	
Hn.	AJ	JP 2000-128192	May-2000	JAPAN (w/abstract)				X	
the	AK	EP 1,014,214	Jun-2005	EUROPEAN					
4,	AL	EP 1,193,570	Nov-2004	EUROPEAN					
-#5	AM	JP 08-211723	Aug-1996	JAPAN (w/abstract)				х	
-Hz	AN	JP 03-241372	Oct-1991	JAPAN (w/abstract)				×	
-H2	AO	JP 08-292636	Nov-1996	JAPAN (w/abstract)				X	
,	AP	JP 02-053055	Feb-1990	JAPAN (w/abstract)				X	
-tn	AQ	JP 08-314272	Nov-1996	JAPAN (w/abstract)				х	
-Th	AR	JP 04-087901	Mar-1992	JAPAN (w/abstract)				x	
	AS	JP 09-106156	Apr-1997	JAPAN (w/abstract)				Х	
#1	AT	JP 61-059464	Mar-1986	JAPAN (w/abstract)		<del> · · · · ·</del>		х	
#~	AU	JP 64-052181	Feb-1989	JAPAN (w/abstract)				×	
#.			Jul-1996	JAPAN (w/abstract)				×	
#	AV	JP 05-232810	Sep-1993	JAPAN (w/abstract)				×	
- <del></del>	AW		Apr-1982	JAPAN (w/abstract)				×	
#	AX		Jul-1994	JAPAN (w/abstract)				x	
-th	AY	JP 06-208301						×	
	AZ	JP 07-261529	Oct-1995	JAPAN (w/abstract)				×	
	AAA	JP 06-191049	Jul-1994	JAPAN (w/abstract)				^x	
#	AAB	JP 09-305080	Nov-1997	JAPAN (w/abstract)					
#_	AAC	JP 06-059572	Mar-1994	JAPAN (w/abstract)				X	
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